


<b>Search Notes</b>  	<b>Application/Control No.</b>  10588871	<b>Applicant(s)/Patent Under Reexamination</b>  SAITO ET AL.
	<b>Examiner</b>  Johnson, Ryan J	<b>Art Unit</b>  2817

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
331	117R,117FE,117D,107SL,167,185,186,166,173	12/4/2007	Ryan Johnson

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
See EAST history	12/4/2007	Ryan Johnson
IEEE search	12/4/2007	Ryan Johnson
Emailed Joseph Chang	12/4/2007	Ryan Johnson

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>